


<b>Search Notes</b>  	<b>Application/Control No.</b>  10584634	<b>Applicant(s)/Patent Under Reexamination</b>  IKEDA ET AL.
	<b>Examiner</b>  ARMANDO P RAMIREZ	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST see attached	3/25/09 all	ARP all	
STIC EIC Search, Huang, Mei Q. see attached	09/26/08		
Inventor lim by text			
Assignee lim by text			

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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